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Feng Li, Han-Dong Yin* and Da-Qi Wang

College of Chemistry and Chemical Engineering, Liaocheng University, Shandong 252059, People's Republic of China

Correspondence e-mail: handongyin@lctu.edu.cn

Key indicators

Single-crystal X-ray study T = 298 K Mean σ (C–C) = 0.010 Å R factor = 0.043 wR factor = 0.110 Data-to-parameter ratio = 15.3

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

(4-Benzylpiperazine-1-carbodithioato)triphenyltin(IV)

In the title complex, $[Sn(C_6H_6)_3(C_{12}H_{15}N_2S_2)]$, the Sn atom is in a distorted tetrahedral configuration.

Comment

The molecular structure and packing of the title compound, (I), are shown in Figs. 1 and 2, respectively. The Sn atom is surrounded by one S atom of the dithiocarbamate ligand and three C atoms of the phenyl groups in a tetrahedral configuration.



Experimental

The sodium salt of N-benzylpiperazinyldithiocarbamate (0.0906 g, 3.3 mmol) was added to a dichloromethane solution (30 ml) of triphenyltin chloride (1.593 g, 3.0 mmol) and the mixture stirred for 14 h. The sodium chloride which precipitated was removed and the solution concentrated. Diethyl ether (5 ml) and hexane (5 ml) were added to this solution to precipitate the product. The product was recrystallized from a dichloromethane-hexane mixture (1:1 v/v) to give colourless crystals of (I) (1.45 g, yield 76%, m.p. 446 K). Analysis calculated for C₃₀H₃₀N₂S₂Sn: C 59.91, H 5.03, N 4.66, S 10.66%; found: C 60.01, H 4.92, N 4.72, S 10.63%.

Crystal data

$[Sn(C_6H_6)_3(C_{12}H_{15}N_2S_2)]$	$D_x = 1.453 \text{ Mg m}^{-3}$
$M_r = 601.37$	Mo $K\alpha$ radiation
Monoclinic, $P2_1/c$	Cell parameters from 2933
a = 19.063 (4) Å	reflections
$b = 9.6915 (19) \text{\AA}$	$\theta = 2.4-21.3^{\circ}$
c = 14.968 (3) Å	$\mu = 1.10 \text{ mm}^{-1}$
$\beta = 96.114 \ (3)^{\circ}$	T = 298 (2) K
V = 2749.4 (9) Å ³	Block, colourless
Z = 4	$0.29 \times 0.23 \times 0.18 \ \text{mm}$

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Data collection

Siemens SMART CCD area-
detector diffractometer
φ and ω scans
Absorption correction: multi-scan
(SADABS; Sheldrick, 1996)
$T_{\min} = 0.741, T_{\max} = 0.826$
14089 measured reflections

Refinement

Refinement on F^2 $R[F^2 > 2\sigma(F^2)] = 0.043$ $wR(F^2) = 0.110$ S = 1.004831 reflections 316 parameters H-atom parameters constrained 3113 reflections with $I > 2\sigma(I)$ $R_{int} = 0.050$ $\theta_{max} = 25.0^{\circ}$ $h = -22 \rightarrow 22$ $k = -11 \rightarrow 8$ $l = -17 \rightarrow 17$

4831 independent reflections

 $w = 1/[\sigma^{2}(F_{o}^{2}) + (0.045P)^{2} + 2.1544P]$ where $P = (F_{o}^{2} + 2F_{c}^{2})/3$ $(\Delta/\sigma)_{max} < 0.001$ $\Delta\rho_{max} = 0.73 \text{ e} \text{ Å}^{-3}$ $\Delta\rho_{min} = -0.38 \text{ e} \text{ Å}^{-3}$

Table 1

Selected geometric parameters (Å, °).

6 1 625 0 122 (6)	N1-C2	1 151 (6)
Sn1 - C2S 2.132 (6)	111-02	1.454 (6)
Sn1-C19 2.154 (5)	N2-C4	1.458 (7)
Sn1-C13 2.178 (5)	N2-C3	1.468 (6)
Sn1-S1 2.4858 (1	5) N2-C6	1.476 (7)
Sn1-S2 2.9222 (1	5) S1-C1	1.738 (5)
N1-C1 1.332 (6)	S2-C1	1.690 (6)
N1-C5 1.453 (7)		
C25-Sn1-C19 115.1 (2)	C25-Sn1-S2	91.05 (15
C25-Sn1-C13 106.9 (2)	C19-Sn1-S2	85.67 (14
C19-Sn1-C13 102.42 (1	9) C13-Sn1-S2	154.31 (15
C25-Sn1-S1 106.26 (1	4) $S1 - Sn1 - S2$	65.33 (5)
C19-Sn1-S1 129.54 (1	4) $C1-S1-Sn1$	94.72 (19
C13-Sn1-S1 91.56 (1	4) $C1 - S2 - Sn1$	81.35 (17

All H atoms were placed in geometrically calculated positions and treated as riding on their parent atoms, with aromatic C–H distances of 0.93 Å and methylene C–H distances of 0.97 Å, and with $U_{iso}(H) = 1.2U_{eq}(C)$.

Data collection: *SMART* (Siemens, 1996); cell refinement: *SAINT* (Siemens, 1996); data reduction: *SAINT*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997*a*); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997*a*); molecular graphics: *SHELXTL* (Sheldrick, 1997*b*); software used to prepare material for publication: *SHELXTL*.

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References

- Sheldrick, G. M. (1996). SADABS. University of Göttingen, Germany.
- Sheldrick, G. M. (1997a). SHELXS97 and SHELXL97. University of Göttingen, Germany.



Figure 1

The structure of (I), with 30% probability displacement ellipsoids. H atoms have been omitted.



Figure 2 The crystal packing of (I). H atoms have been omitted.

Sheldrick, G. M. (1997b). SHELXTL (Version 5.10). Bruker AXS Inc., Madison, Wisconsin, USA.

Siemens (1996). *SMART* and *SAINT*. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.